



# W Influx Measurements in ASDEX Upgrade

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Sino-German Workshop, 7.12.2010, Garching, Germany

#### Introduction



- experimental setup for spectroscopic W influx measurements
- comparison with erosion measurements
- evolution of W influx profiles during H-Mode discharges
  - effect of ELMs
  - effect ICRF heating
- yield for physical sputtering of W
- influence of W influx from different regions on W content in confined plasma

#### ASDEX Upgrade with W Plasma Facing Components



## **Spectroscopic setup for W influx measurements**

- small optical heads in shadowed areas
- silica fibers (Ø400µm,~25dB/km at 400nm)
- spectrometer(180mm, f#=2.8) + back-illum. CCD
- WI (400.8nm)





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observation of outer divertor with 12 lines-of-sight (7 lines-of-sight in 2007)

- 1 fast channel with  $\Delta t$ =200 $\mu$ s
- remaining channels with  $\Delta t=3ms$
- WI line at 400.9nm
- W influx from photon flux using S/XB=20.



# Example of spectra measured in the outer divertor

WI line: weak but quite well separated

exposure time 200µs



# Total Erosion in 2007 Campaign (check spectroscopy against surface analysis)

- change of layer thickness with RBS of a 1.5µm thick W-coating on C
- ∆d≈0.2 µm (0.12nm/s) spatial average, microscopic variations due to surface roughness)
- compares well with spectroscopic erosion fluences (measure of all erosion events)
- data uncertainty of spec.about a factor of 2



 large prompt redeposition expected (typ. scales λ\_ion=0.1mm, r\_gyro=2.5mm)

\*spec. W fluence multiplied with:  $\Delta t_t = \frac{1}{\Delta t_t}$ 

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in H-mode plasmas:

- modulation of erosion profiles with arrival of energy bursts due to type-I ELMs
- time resolution (3ms) sufficient to measure erosion between ELMs







#### $\Delta t$ =200 $\mu$ s

- strong increase of influx density with ELMs
- between ELMs: influx decreases with electron temperature at target (recycling level, distance to strike point ...)
- overall ELM contribution c\_ELM to average influx density varies from 40-90%



(Te,div from Langmuir probes)

#### **Tungsten Erosion Rates in the Outer Divertor**



Profile Measurements

- hot divertor
  - T\_e≈20eV near strike point
  - highest erosion rates (up to 2E20/s)
  - 50% erosion between ELMs

- cold divertor
  - T\_e≈6eV near strike point
  - erosion dominated by ELMs (80%)
- number of eroded W atoms per ELM
  - rises with ELM energy (max. 1E18)
  - also here pure D sputtering not sufficient to explain erosion



#### Tungsten sources in the main chamber





R[m]

main erosion areas

**High Field Side** 

- inner column
  - covered by a toroidally symmetric heat shield without protruding elements
  - largest area (8.5m\*\*2)

Low Field Side

- window frames around the 4 ICRF antennas
- 4 limiters next to NBI ports

### Spectroscopic observation of low-field side limiters



#### 17 lines-of-sight on window frames around ICRF antennas

 $\Delta t$ =3.4ms





# W Erosion profile along the poloidal ICRH limiter



 contribution of ELMs to total erosion flux (70±10)%

- profile peaks at the position, where SOL plasma is limited
  - usually on upper part of limiter



# W Erosion profile along the poloidal ICRH limiter



- contribution of ELMs to total erosion flux (70±10)%
- profile peaks at the position, where SOL plasma is limited
  - usually on upper part of limiter
  - in a few cases on the lower part of the limiter
- radial decay length in both cases ≈1cm



#### Increase of limiter source and tungsten concentration with ICRF

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- ICRF heating causes strong increase of limiter erosion and tungsten concentration
- effect is due to increase of sheath potential drop causing an increase of the W sputtering yield
- optimization of ICRF antennas





# Effect of Type-I ELMs on the W Erosion at the Limiters

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ELM resolved measurements of total W erosion on:

- inner column (∆t=1.2ms)
- outboard limiters (∆t=0.5ms)

During ELMs drastic increase of W source at ouboard limiters by more than a factor of 10

mean temporal shape

- rise time  $\approx 0.35$  ms
- FWHM ≈ 0.85ms



#### W Erosion profile along the inner column



 $\Delta t$ =3ms

 flat erosion profile, if flux surfaces are well aligned with heat shield



#### W Erosion profile along the inner column









- at heat shield: 40-60%
- smaller more frequent ELMs have same effect as larger less frequent ELMs



#### Balance of W Erosion during ELMs: Main Chamber versus Divertor



W erosion at main chamber PFCs releases 10-20% of the W atoms eroded in the divertor.



# W source balance between heat shield and outboard limiters depends on distance to separatrix



flux surface label  $\Delta \mathbf{R}$ 

- distance to separatrix measured on the outer equator

Expect the first limiting surface with lowest  $\Delta R$  to be the predominant W source





- between ELMs the balance is in acordance with a parallel loss onto the first limiting element (within uncertainties of the magnetic equilibrium and the erosion measurements)
- during ELMs the balance is shifted to the outboard side (filaments)

#### ratio of W influx limiter/heat shield versus radial position of the plasma column





#### simple estimate of ion energy $E = 2 k_B T_i + 3 Z k_B T_e$



In the relevant temperature range W sputtering is mainly caused by light impurities

since impurities have

- a higher mass
- and a higher energy gain in the sheath (Z>1)

High tungsten influx expected for large temperatures  $\rightarrow$  ELMs

### Effective erosion yield between ELMs



#### between ELMs

- ratio of tungsten influx density to the ion saturation flux yields a measure for the effective erosion yield (estimated systematic error ± factor of 2)
- effective yield as function of T\_e at target can only be understood for dominant erosion by impurity ions



#### Measurement of Tungsten Source and Confined Tungsten Density



# Source of neutral W from all major erosion areas

- WI line at 400.9nm
  - heat shield: 9 lines-of-sight
  - outer limiters: 17 lines-of-sight
  - outer divertor: 12 lines-of-sight

#### W density in confined plasma

 W quasi-continuum at 5nm emitted by ion stages existing around T≈1.5keV<sup>-</sup> typ. r/a ≈0.8



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# Comparison of different PFCs: Source Strength and Effect on W Concentration



radial sweeps of outer plasma radius at two puff levels

divertor source dominant

tungsten concentration modulates with the limiter source

mean tungsten concentration increases with the ELM period (ELM period is controled by puff level)



#### **Summary**



Fast spectroscopic W influx measurements at all major erosion areas in ASDEX Upgrade

- give insight into the main mechanisms, which cause erosion of tungsten at the plasma facing components.
- are necessary to identify the dominant effects of different operation modes onto the sputtering of tungsten.
- are the basis for an understanding of the transport of W from the plasma facing component into the confined plasma.
  - A major goal is to understand the tungsten confinement in a fusion plasma (→ see next talk by T. Pütterich).